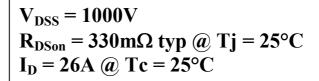
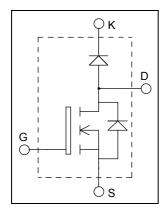


ISOTOP® Boost chopper MOSFET + SiC chopper diode Power module





Application

- AC and DC motor control
- Switched Mode Power Supplies
- **Power Factor Correction**
- Brake switch

Features

Power MOS 8TM MOSFET

- Low R_{DSon}
- Low input and Miller capacitance
- Low gate charge
- Avalanche energy rated

• SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- ISOTOP® Package (SOT-227)
- Very low stray inductance
- High level of integration

Benefits

- Outstanding performance at high frequency
- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive TC of VCEsat
- **RoHS Compliant**

Absolute maximum ratings

ISOTOP®

Symbol	Parameter		Max ratings	Unit
$V_{ m DSS}$	Drain - Source Breakdown Voltage		1000	V
T	Continuous Drain Current	$T_c = 25^{\circ}C$	26	
I_D	Continuous Drain Current	$T_c = 80$ °C	20	A
I_{DM}	Pulsed Drain current	•		
V_{GS}	Gate - Source Voltage		±30	V
R_{DSon}	Drain - Source ON Resistance		396	mΩ
P_D	Maximum Power Dissipation	$T_c = 25^{\circ}C$	543	W
I_{AR}	Avalanche current (repetitive and non repetitive)		18	A

These Devices are sensitive to Electrostatic Discharge. Proper Handing Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



All ratings @ $T_j = 25$ °C unless otherwise specified

Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 1000V$	$T_j = 25^{\circ}C$			100	^
		$V_{GS} = 0V$	$T_j = 125$ °C			500	μΑ
R _{DS(on)}	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 18A$			330	396	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 2.5 \text{mA}$		3	4	5	V
I_{GSS}	Gate – Source Leakage Current	$V_{GS} = \pm 30 \text{ V}$				±100	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
C_{iss}	Input Capacitance	$V_{GS} = 0V$		7868		
C_{oss}	Output Capacitance	$V_{DS} = 25V$		825		pF
C_{rss}	Reverse Transfer Capacitance	f = 1MHz		104		
Q_{g}	Total gate Charge	$V_{GS} = 10V$		305		
Q_{gs}	Gate – Source Charge	$V_{Bus} = 500V$		55		nC
Q_{gd}	Gate – Drain Charge	$I_D = 18A$		145		
$T_{d(on)}$	Turn-on Delay Time	Resistive switching @ 25°C		44		
T_{r}	Rise Time	$V_{GS} = 15V$		40		
$T_{d(off)}$	Turn-off Delay Time	$V_{\text{Bus}} = 667V$ $I_{\text{D}} = 18A$		150		ns
$T_{\rm f}$	Fall Time	$R_G = 2.2\Omega$		38		

SiC chopper diode ratings and characteristics

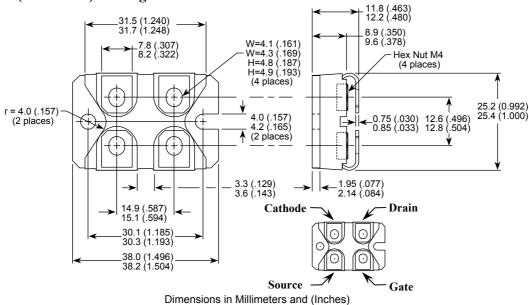
	Characteristic	Test Conditions		Min	Тур	Max	Unit
V_{RRM}	Maximum Peak Repetitive Reverse Voltage			1200			V
Ţ	Maximum Payarga Lagkaga Current	V _R =1200V	$T_j = 25^{\circ}C$		32	200	^
I_{RM}	Maximum Reverse Leakage Current	$V_{R}-1200V$ $T_{j} = 175^{\circ}C$	$T_j = 175$ °C		56	1000	μΑ
I_F	DC Forward Current		Tc = 100°C		10		Α
$V_{\rm F}$	Diode Forward Voltage	$1_{2} = 100$	$T_j = 25^{\circ}C$		1.6	1.8	V
v _F			$T_j = 175$ °C		2.3	3	v
Q_{C}	Total Capacitive Charge	$I_F = 10A, V_R = 600V$ di/dt = 500A/ μ s			80		nC
С	Total Capacitance	$f = 1MHz, V_R =$	= 200V		96		mE.
		$f = 1MHz, V_R =$	= 400V		69		pF

Thermal and package characteristics

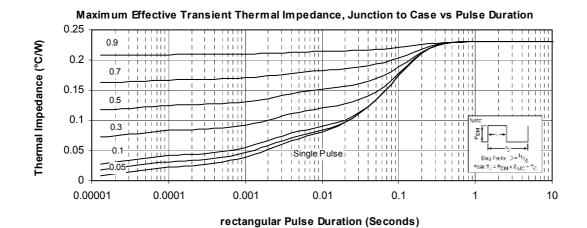
Symbol	Characteristic		Min	Тур	Max	Unit
R _{thJC}	Junction to Case Thermal Resistance	Mosfet			0.23	
NthJC		SiC Diode			1.65	°C/W
R_{thJA}	Junction to Ambient (IGBT & Diode)				20	
V_{ISOL}	RMS Isolation Voltage, any terminal to case t = 1 min, 50/60Hz		2500			V
T_{J}, T_{STG}	Storage Temperature Range		-40		150	°C
$T_{ m L}$	Max Lead Temp for Soldering:0.063" from case for 10 sec				300	
Torque	Mounting torque (Mounting = 8-32 or 4mm Machine and terminals = 4mm Machine)				1.5	N.m
Wt	Package Weight			29.2		g



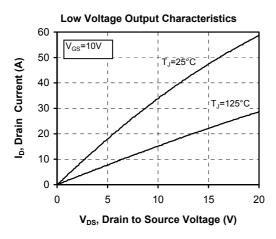
SOT-227 (ISOTOP®) Package Outline

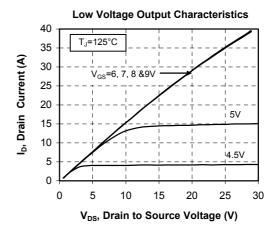


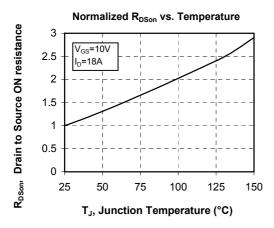
Typical Mosfet Performance Curve

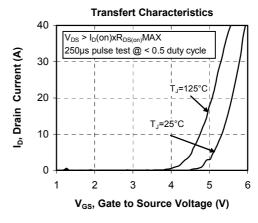


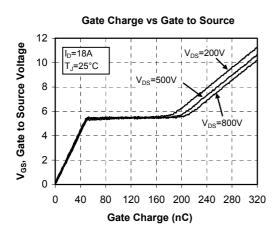


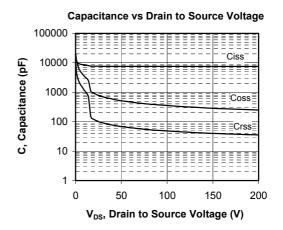






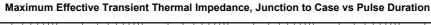


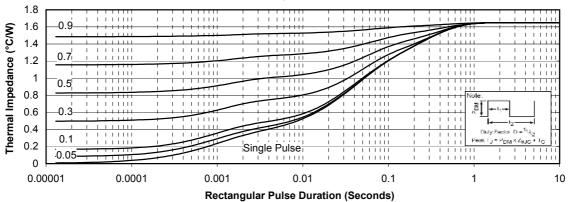


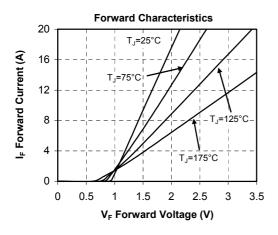


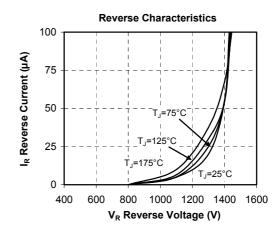


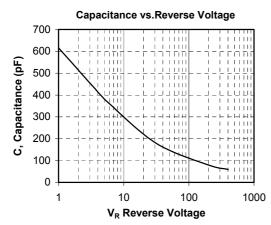
Typical SiC Diode Performance Curve











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